



HAC RF Test Report

For

Applicant Name: Zhejiang Lianyong Intelligent Technology Co., Ltd.
Address: No. 1, First Street, Eastern New Area, Wenling, Taizhou, Zhejiang, China
EUT Name: Mobile phone
Brand Name: MAZE SPEED, SOHO STYLE
Model Number: MS5614G
Series Model Number: Refer to section 2

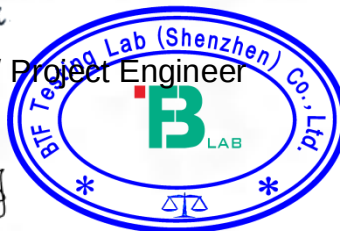
Issued By

Company Name: BTF Testing Lab (Shenzhen) Co., Ltd.
Address: F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Report Number: BTF230613R00401
Test Standards: ANSI C63.19-2011 FCC 47 CFR §20.19 KDB 285076 D01v06
KDB 285076 D02v04 KDB 285076 D03v01r05
FCC ID: 2BBW3-MS5614G

Test Conclusion: Pass
Test Date: 2023-06-30
Date of Issue: 2023-06-30

Prepared By: 
Date: 2023-06-30
Approved By: 
Date: 2023-06-30



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Revision History		
Version	Issue Date	Revisions Content
R_V0	2023-06-30	Original
Note:	Once the revision has been made, then previous versions reports are invalid.	

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1. Introduction

1.1 Identification of Testing Laboratory

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Phone Number:	+86-0755-23146130
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1.2 Identification of the Responsible Testing Location

Test Location:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Description:	All measurement facilities used to collect the measurement data are located at F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
FCC Registration Number	518915
Designation Number	CN1330

1.3 Laboratory Condition

Ambient Temperature:	21°C to 25°C
Ambient Relative Humidity:	48% to 59%
Ambient Pressure:	100 kPa to 102 kPa

1.4 Announcement

- (1) The test report reference to the report template version v0.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing, reviewing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
- (4) This document may not be altered or revised in any way unless done so by BTF and all revisions are duly noted in the revisions section.
- (5) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
- (6) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.

2. Product Information

2.1 Application Information

Company Name:	Zhejiang Lianyong Intelligent Technology Co., Ltd.
Address:	No. 1, First Street, Eastern New Area, Wenling, Taizhou, Zhejiang, China

2.2 Manufacturer Information

Company Name:	Zhejiang Lianyong Intelligent Technology Co., Ltd.
Address:	No. 1, First Street, Eastern New Area, Wenling, Taizhou, Zhejiang, China

2.3 Factory Information

Company Name:	Zhejiang Lianyong Intelligent Technology Co., Ltd.
Address:	No. 1, First Street, Eastern New Area, Wenling, Taizhou, Zhejiang, China

2.4 General Description of Equipment under Test (EUT)

EUT Name	Mobile phone
Under Test Model Name	MS5614G
Series Model Name	SS5614G
Description of Model name differentiation	Only the model name and brand name are different, others are the same.
Sample No.	BTFSN230612E007-1/5

2.5 Equipment under Test Ancillary Equipment

Ancillary Equipment 1	Rechargeable Battery	
	Capacity	2100mAh
	Rated Voltage	3.7V

2.6 Technical Information

Network and Wireless connectivity	2G Network GSM/GPRS/EGPRS 850/1900 3G Network WCDMA/HSDPA/HSUPA Band 2/4/5 4G Network FDD LTE Band 2/4/5/12/17/30/66/71 2.4G WIFI 802.11b, 802.11g, 802.11n(HT20/HT40) 5G WIFI 802.11a, 802.11n(HT20/HT40) BT (EDR+BLE)
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2.7 Air Interfaces / Bands Indicating Operating Modes

Air Interface	Band	Type	Simultaneous Transmitter	Name of Service
GSM	850	VO	WLAN & BT	CMRS Voice
	1900	VO	WLAN & BT	CMRS Voice
	GPRS/EGPRS	DT	N/A	N/A
WCDMA	Band II	VO	WLAN & BT	CMRS Voice
	Band IV	VO	WLAN & BT	CMRS Voice
	Band V	VO	WLAN & BT	CMRS Voice
	HSPA	DT	N/A	N/A
LTE	Band 2	VD	WLAN & BT	VoLTE
	Band 4	VD	WLAN & BT	VoLTE
	Band 5	VD	WLAN & BT	VoLTE
	Band 12	VD	WLAN & BT	VoLTE
	Band 17	VD	WLAN & BT	VoLTE
	Band 30	VD	WLAN & BT	VoLTE
	Band 66	VD	WLAN & BT	VoLTE
	Band 71	VD	WLAN & BT	VoLTE
WLAN	2.4g & 5g	DT	WWAN	N/A
BT	2450	DT	WWAN	N/A

NA: Not Applicable
VO: Voice Only
VD: CMRS and IP Voice Service over Digital Transport
DT: Digital Transport Only

* HAC Rating was not based on concurrent voice and data modes; Noncurrent mode was found to represent worst case rating for both M and T rating.
Note1: The air interface is exempted from testing by low power exemption that its average antenna input power plus its MIF is ≤ 17 dBm, and is rated as M4.
Note2: According to ANSI C63.19 2011-version, for the air interface technology of a device is exempt from testing whose peak antenna input power, averaged over intervals ≤ 50 μ s, is ≤ 23 dBm. An RF air interface technology that is exempted from testing shall be rated as M4.

3. Summary of Test Results

3.1 Test Standards

No.	Identity	Document Title
1	ANSI C63.19-2011	American National Standard for Methods of Measurement of Compatibility between Wireless Communication Devices and Hearing Aids
2	FCC 47 CFR §20.19	Hearing Aid Compatible Mobile Headsets
3	KDB 285076 D01v06	Equipment Authorization Guidance for Hearing Aid Compatibility
4	KDB 285076 D02v04	Guidance for performing T-Coil tests for air interfaces supporting voice over IP (e.g., LTE and WiFi) to support CMRS based telephone services
5	KDB 285076 D03v01r05	Hearing aid compatibility frequently asked questions

3.2 ANSI C63.19 HAC RF Categories

The ANSI Standard presents performance requirements for acceptable interoperability of hearing with wireless communications devices. When these parameters are met, a hearing aid operates acceptably in close proximity to a wireless communications device.

WD RF audio Interference level categories in logarithmic units

Emission categories	<960MHz Limits for E-field emissions	>960MHz Limits for E-field emissions
M1	50 to 55 dB (V/m)	40 to 45 dB (V/m)
M2	45 to 50 dB (V/m)	35 to 40 dB (V/m)
M3	40 to 45 dB (V/m)	30 to 35 dB (V/m)
M4	< 40 dB (V/m)	< 30 dB (V/m)

3.3 Summary of HAC M-Rating

Band	Channel	Measurement Result		M-Rating
GSM850	Low (128)	E-Field dB (V/m)	33.40	M4
	Middle(190)	E-Field dB (V/m)	34.11	M4
	High(251)	E-Field dB (V/m)	33.52	M4
GSM1900	Low (512)	E-Field dB (V/m)	27.22	M4
	Middle(661)	E-Field dB (V/m)	27.20	M4
	High(810)	E-Field dB (V/m)	28.08	M4
HAC Rate Category: M4				

3.4 HAC Test Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in ANSI C6 3.19: 2011. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=2$.

UNCERTAINTY EVALUATION FOR RF HAC MEASUREMENT					
Uncertainty Component	Tol ($\pm$ dB)	Prob. Dist.	Div.	Uncertainty (dB)	Uncertainty (%)
Measurement System					
RF reflections	0.1	R	$\sqrt{3}$	0.06	
Field probe conv. Factor	0.4	R	$\sqrt{3}$	0.23	
Field probe anisotropy	0.25	R	$\sqrt{3}$	0.14	
Positioning accuracy	0.2	R	$\sqrt{3}$	0.12	
Probe cable placement	0.1	R	$\sqrt{3}$	0.06	
System repeatability	0.2	R	$\sqrt{3}$	0.12	
EUT repeatability	0.4	N	1	0.40	
Combined Standard Uncertainty		N	1	0.52	
Expanded Uncertainty (95% CONFIDENCE INTERVAL)		N	$K=2$	1.03	12.65
REPORTED Expanded uncertainty (confidence level of 95%, $k = 2$)		N	$K=2$	1.00	13.00

4. Measurement System

4.1 Definition of Hearing Aid Compatibility (HAC)

The purpose of this standard is to establish categories for hearing aids and for WD (wireless communications devices) that can indicate to health care practitioners and hearing aid users which hearing aids are compatible with which WD, and to provide tests that can be used to assess the electromagnetic characteristics of hearing aids and WD and assign them to these categories. The various parameters required, in order to demonstrate compatibility and accessibility are measured. The design of the standard is such that when a hearing aid and WD achieve one of the categories specified, as measured by the methodology of this standard, the indicated performance is realized.

In order to provide for the usability of a hearing aid with a WD, several factors must be coordinated:

- a) Radio frequency (RF) measurements of the near-field electric and magnetic fields emitted by a WD to categorize these emissions for correlation with the RF immunity of a hearing aid.
- b) Magnetic field measurements of a WD emitted via the audio transducer associated with the T-coil mode of the hearing aid, for assessment of hearing aid performance.
- c) Measurements with the hearing aid and a simulation of the categorized WD T-coil emissions to assess the hearing aid RF immunity in the T-coil mode.

The WD radio frequency (RF) and audio band emissions are measured.

Hence, the following are measurements made for the WD:

- a) RF E-Field emissions
- b) T-coil mode, magnetic signal strength in the audio band
- c) T-coil mode, magnetic signal and noise articulation index
- d) T-coil mode, magnetic signal frequency response through the audio band

Corresponding to the WD measurements, the hearing aid is measured for:

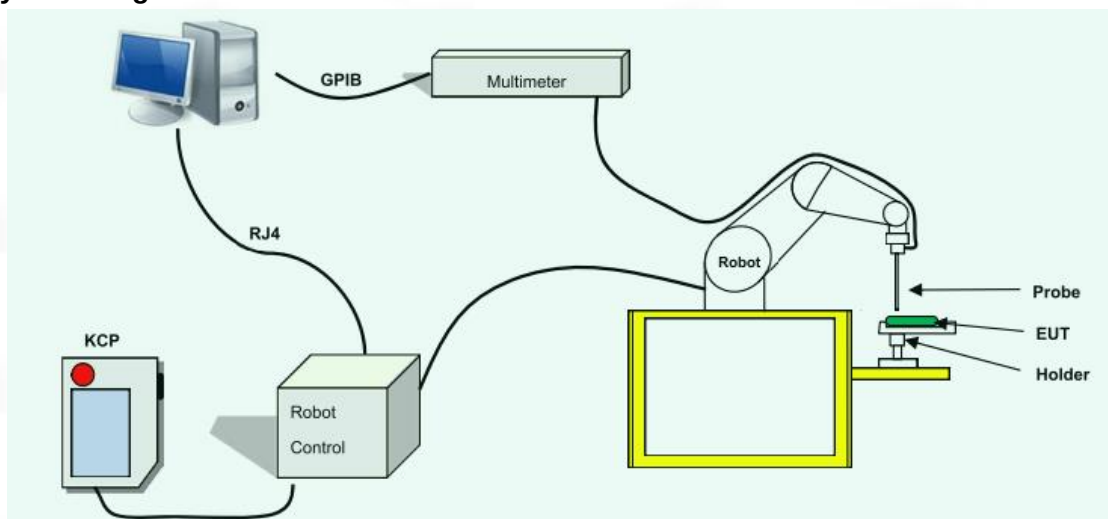
- a) RF immunity in microphone mode
- b) RF immunity in T-coil mode

4.2 HAC RF Test Configuration and Setting

For HAC RF emission testing, the EUT was linked and controlled by wireless communication test set. Communication between the EUT and the wireless communication test set was established by air link. The distance between the EUT and the communicating antenna of the test set is larger than 50 cm and the output power radiated from the wireless communication test set antenna is at least 30 dB smaller than the output power of EUT. The EUT was set from the wireless communication test set to radiate maximum output power during HAC testing.

4.3 MVG HAC System

MVG HAC System Diagram



4.3.1 Robot



A standard high precision 6-axis robot (Denso) with a scanning system pendant.

- It must be able to scan all the volume of the phantom to evaluate the tridimensional distribution of SAR.
- Must be able to set the probe orthogonal to the surface of the phantom ($\pm 30^\circ$).
- Detects stresses on the probe and stops itself if necessary to keep the integrity of the probe.

4.3.2 E-Field Probe

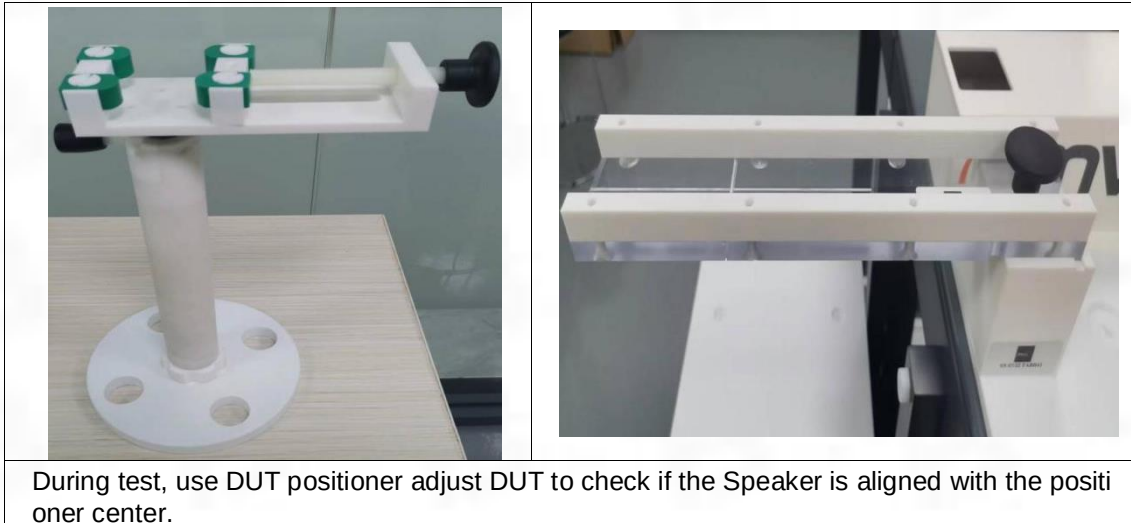


Figure 1 – MVG COMO-HAC E field Probe

Probe Length	330 mm
Length of Individual Dipoles	3.3 mm
Maximum external diameter	8 mm
Probe Tip External Diameter	5 mm
Distance between dipoles / probe extremity	3 mm

Device Type	COMO-HAC E FIELD PROBE
Manufacturer	MVG
Model	SCE
Serial Number	SN 07/22 EPH50
Product Condition (new / used)	New
Frequency Range of Probe	0.7GHz-2.5GHz
Resistance of Three Dipoles at Connector	Dipole 1: $R_1=0.208 \text{ M}\Omega$ Dipole 2: $R_2=0.220 \text{ M}\Omega$ Dipole 3: $R_3=0.212 \text{ M}\Omega$

4.3.3 Device Holder/DUT positioner

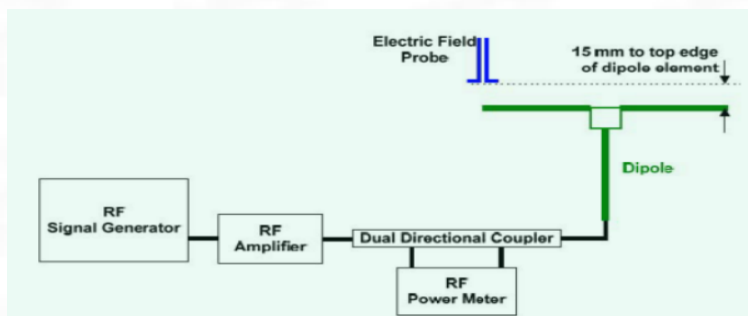


5. System Validation

According to ANSI C63.19, before hearing aid testing commences, the experimental setup shall be validated. Sub clauses 6.3.1 through 6.3.5 include a set of pretest procedures designed to validate the experimental setup to ensure the accuracy of the results. To verify that the hearing aid performs per the manufacturer's specifications, 6.3.5 advises that the hearing aid be pretested per ANSI S3.22.

5.1 System Validation Setup

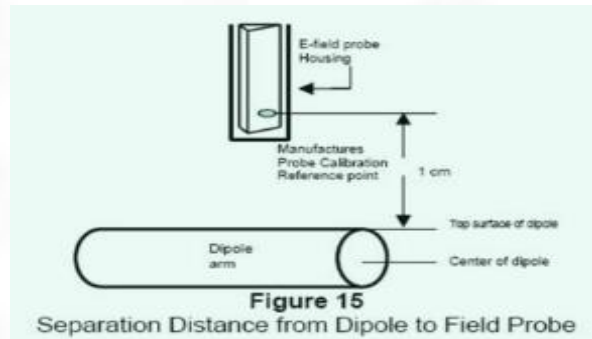
Using this setup configuration, the signal generator was adjusted for the desired output power 20dBm (100mW) at a specified frequency. The reference power from the coupled port of the directional coupler is recorded. Next, the output cable is connected to the reference dipole



5.2 System Check Procedure

The input signal was an unmodulated continuous wave. The following points were taken into consideration in performing this check:

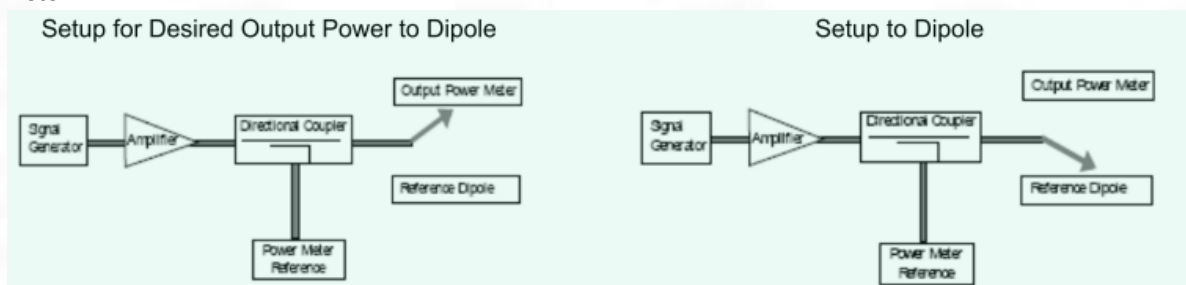
- Average Input Power $P = 100\text{mW RMS}$ (20dBm RMS) after adjustment for return loss
- The test fixture must meet the 2 wavelength separation criterion
- The proper measurement of the 1 cm probe to dipole separation, which is measured from top surface of the dipole to the calibration reference point of the sensor, defined by the probe manufacturer is shown in the following diagram:



RF power was recorded using both an average reading meter and a peak reading meter. Readings of the probe are provided by the measurement system. To assure proper operation of the near-field measurement probe the input power to the dipole shall be commensurate with the full rated output power of the wireless device (e.g. – for a cellular phone wireless device the average peak antenna input power will be on the order of 100mW (i.e. - 20dBm) RMS after adjustment for any mismatch.

5.3 System Validation Procedure

A dipole antenna meeting the requirements given in C63.19 was placed in the position normally occupied by the WD. The length of the dipole was scanned with both E-field and H-field probes and the maximum values for each were recorded. Using the near-field measurement system, scan the antenna over the radiating dipole and record the greatest field reading observed. Due to the nature of E-fields about free-space dipoles, the two E-field peaks measured over the dipole are averaged to compensate for non-parallelity of the setup see manufacturer method on dipole calibration certificates, Field strength measurements shall be made only when the probe is stationary. RF power was recorded using both an average and a peak power reading meter.



6. Modulation Interference Factor (MIF)

The HAC Standard ANSI C63.19-2011 defines a new scaling using the Modulation Interference Factor (MIF). For any specific fixed and repeatable modulated signal, a modulation interference factor (MIF, expressed in dB) may be developed that relates its interference potential to its steady-state rms signal level or average power level. This factor is a function only of the audio-frequency amplitude modulation characteristics of the signal and is the same for field-strength and conducted power measurements. It is important to emphasize that the MIF is valid only for a specific repeatable audio-frequency amplitude modulation characteristic. Any change in modulation characteristic requires determination and application of a new MIF.

The MIF may be determined using a radiated RF field, a conducted RF signal, or in a preliminary stage, a mathematical analysis of a modeled RF signal:

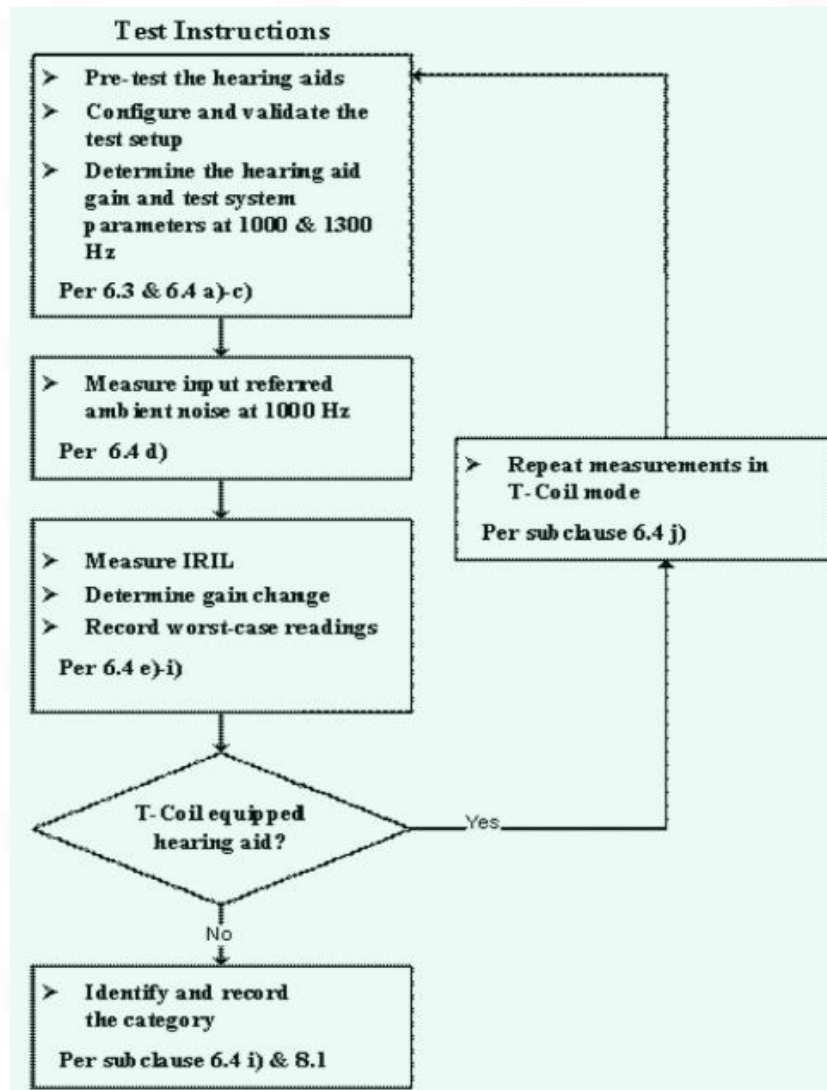
- a) Verify the slope accuracy and dynamic range capability over the desired operating frequency band of a fast probe or sensor, square-law detector, as specified in D.3, and weighting system as specified in D.4 and D.5. For the probe and instrumentation included in the measurement of MIF, additional calibration and application of calibration factors are not required.
- b) Using RF illumination or conducted coupling, apply the specific modulated signal in question to the measurement system at a level within its confirmed operating dynamic range.
- c) Measure the steady-state rms level at the output of the fast probe or sensor.
- d) Measure the steady-state average level at the weighting output.
- e) Without changing the square-law detector or weighting system, and using RF illumination or conducted coupling, substitute for the specific modulated signal a 1kHz, 80% amplitude-modulated carrier at the same frequency and adjust its strength until the level at the weighting output equals the step d) measurement.
- f) Without changing the carrier level from step e), remove the 1 kHz modulation and again measure the steady-state rms level indicated at the output of the fast probe or sensor.
- g) The MIF for the specific modulation characteristic is provided by the ratio of the step f) measurement to the step c) measurement, expressed in dB ($20 \times \log(\text{step f})/\text{step c})$).

In practice, step e) and step f) need not be repeated for each MIF determination if the relationship between the two measurements has been preestablished for the measurement system over the operating frequency and dynamic ranges.

Modulation group	Modulation characteristics	MIF
CW	CW	-99.0
GSM	TDMA	3.3
WCDMA	UMTS-FDD	-27.2
LTE	LTE-FDD / RB=1 / BW=20 MHz / QPSK	-15.6

7. HAC Immunity Measurement Procedures

7.1 HAC Measurement Process Diagram



7.2 HAC RF Test Setup



WD reference and plane for RF emission measurements

7.3 RF Emission Measurement Procedures

The following illustrate a typical RF emissions test scan over a wireless communications device:

- Proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.
- WD is positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
- WD operation for maximum rated RF output power was configured and confirmed with the base station simulator, at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test.
- center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The WD audio output was positioned tangent (as physically possible) to the measurement plane.
- surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the HAC Phantom.
- measurement system measured the field strength at the reference location

8. Max. Conducted RF Output Power

2G

Mode: GSM850	Maximum Tune-up(dBm)	Burst Average Power (dBm)		
		CH128	CH190	CH251
		824.2MHz	836.6MHz	848.8MHz
GSM	32.50	32.18	32.26	32.14
Mode: GSM1900	Maximum Tune-up(dBm)	Burst Average Power (dBm)		
		CH512	CH661	CH810
		1850.2MHz	1880.0MHz	1909.8MHz
GSM	28.00	26.73	27.52	27.76

3G

Mode	Maximum Tune-up(dBm)	WCDMA Band II		
		Conducted Power (dBm)		
		CH9262	CH9400	CH9538
RMC 12.2K	20.00	1852.4	1880.0	1907.6
		19.39	19.88	19.71
Mode	Maximum Tune-up(dBm)	WCDMA Band IV		
		Conducted Power (dBm)		
		CH1312	CH1413	CH1513
RMC 12.2K	17.00	1712.4	1732.6	1752.6
		16.69	13.56	10.65
Mode	Maximum Tune-up(dBm)	WCDMA Band V		
		Conducted Power (dBm)		
		CH4132	CH4183	CH4233
RMC 12.2K	22.00	826.4	836.6	846.6
		21.80	21.80	21.74

4G

LTE-FDD Band 2				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		18700	18900	19100
					1860.0MHz	1880.0MHz	1900.0MHz
20MHz	QPSK	1	0	20.50	19.50	19.67	20.18
			49	21.00	19.96	20.50	20.32
			99	20.50	19.61	20.22	19.93
		50	0	19.50	18.73	19.13	19.42
			25	19.50	18.84	19.31	19.22
			50	19.50	18.74	19.48	19.21
		100	0	19.50	18.75	19.36	19.33

LTE-FDD Band 4				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20070	20175	20300
					1722.0MHz	1732.5MHz	1745.0MHz
20MHz	QPSK	1	0	17.50	17.42	15.05	13.05
			49	16.50	16.01	14.06	12.09
			99	15.00	14.70	12.31	10.77
		50	0	16.00	15.72	13.56	11.61
			25	15.00	14.99	12.92	10.97
			50	14.50	14.26	12.27	10.40
		100	0	15.50	15.09	12.92	11.03

LTE-FDD Band 5				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20450	20525	20600
					829.0MHz	836.5MHz	844.0MHz
10MHz	QPSK	1	0	22.50	22.03	21.91	21.85
			24	22.50	22.24	22.01	21.94
			49	22.00	21.96	21.83	21.82
		25	0	21.50	21.07	21.00	20.97
			12	21.50	21.04	20.95	20.95
			25	21.50	21.06	20.94	20.90
		50	0	21.50	21.06	20.98	20.94

LTE-FDD Band 12				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		23060	23095	23130
					704.0MHz	707.5MHz	711.0MHz
10MHz	QPSK	1	0	22.00	21.53	21.55	21.72
			24	22.00	21.83	21.81	21.91
			49	22.00	21.80	21.70	21.84
		25	0	21.00	20.75	20.66	20.67
			12	21.00	20.64	20.74	20.83
			25	21.00	20.78	20.84	20.79
		50	0	21.00	20.76	20.78	20.71

LTE-FDD Band 17				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		23780	23790	23800
					709.0MHz	710.0MHz	711.0MHz
10MHz	QPSK	1	0	22.00	21.75	21.71	21.79
			24	22.50	22.03	21.97	21.96
			49	22.00	21.91	21.87	21.94
		25	0	21.00	20.80	20.73	20.78
			12	21.00	20.94	20.89	20.91
			25	21.50	21.02	20.89	20.85
		50	0	21.00	20.90	20.85	20.81

LTE-FDD Band 30				Maximum Tune-up(dBm)	Conducted Power(dBm)	
Bandwidth	Modulation	RB allocation	RB offset		27710	
					2310MHz	
10MHz	QPSK	1	0	22.00	21.56	
			24	21.50	21.22	
			49	21.50	21.00	
		25	0	20.50	20.00	
			12	20.00	19.97	
			25	20.00	19.88	
		50	0	20.00	19.97	

LTE-FDD Band 66				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		132072	132322	132572
					1720.0MHz	1745.0MHz	1770.0MHz
20MHz	QPSK	1	0	22.50	22.41	22.24	21.91
			50	23.00	22.77	22.53	22.27
			99	22.50	22.34	22.04	21.84
		50	0	22.00	21.74	21.40	21.22
			25	22.00	21.64	21.43	21.20
			50	22.00	21.61	21.34	21.17
		100	0	22.00	21.67	21.39	21.19

LTE-FDD Band 71				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		133222	133322	133372
					673.0MHz	683.0MHz	688.0MHz
20MHz	QPSK	1	0	21.50	21.39	21.27	21.26
			50	22.00	21.70	21.55	21.57
			99	21.50	21.29	21.27	21.36
		50	0	21.00	20.70	20.41	20.55
			25	21.00	20.59	20.47	20.47
			50	21.00	20.72	20.44	20.51
		100	0	21.00	20.73	20.44	20.49

9. Low-Power Exemption

9.1 Tune-up Power

Mode	Tune-up Power (dBm)
GSM 850	32.50
GSM 1900	28.00
WCDMA II	20.00
WCDMA IV	17.00
WCDMA V	22.00
LTE Band 2	21.00
LTE Band 4	17.50
LTE Band 5	22.50
LTE Band 12	22.00
LTE Band 17	22.50
LTE Band 30	22.00
LTE Band 66	23.00
LTE Band 71	22.00

9.2 RF Emissions Lower Power Exemption

Mode	Tune-up Power (dBm)	MIF	Power + MIF(dB)	C63.19 Test Required?
GSM 850	32.50	3.3	35.80	Yes
GSM 1900	28.00	3.3	31.30	Yes
WCDMA II	20.00	-27.2	-7.20	No
WCDMA IV	17.00	-27.2	-10.20	No
WCDMA V	22.00	-27.2	-5.20	No
LTE Band 2	21.00	-15.6	5.40	No
LTE Band 4	17.50	-15.6	1.90	No
LTE Band 5	22.50	-15.6	6.90	No
LTE Band 12	22.00	-15.6	6.40	No
LTE Band 17	22.50	-15.6	6.90	No
LTE Band 30	22.00	-15.6	6.40	No
LTE Band 66	23.00	-15.6	7.40	No
LTE Band 71	22.00	-15.6	6.40	No

10. Test Equipment List

Description	Manufacturer	Model	Serial No./Version	Cal. Date	Cal. Due
PC	Dell	N/A	N/A	N/A	N/A
Test Software	MVG	N/A	OpenHAC V5.1.3	N/A	N/A
COMOHAC E-field Probe	MVG	SCE	07/22 EPH50	2023/02/06	2024/02/05
COMOHAC 800-950MHz reference dipole	MVG	SIDB835	07/22 DHA69	2023/02/06	2024/02/05
COMOHAC 1700-2000MHz reference dipole	MVG	SIDB1900	07/22 DHB70	2023/02/06	2024/02/05
6 1/2 Digital Multimeter	Keithley	DMM6500	4527164	2022/11/24	2023/11/23
MXG Vector Signal Generator	Agilent	N5182A	MY46240163	2022/11/24	2023/11/23
E-Series Avg. Power Sensor	KEYSIGHT	E9300A	MY55050017	2023/03/24	2024/03/23
EPM Series Power Meter	KEYSIGHT	E4418B	MY41293435	2023/03/24	2024/03/23
10DB Attenuator	MIDWEST MICROWAVE	263-10dB	/	2023/03/24	2024/03/23
Coupler	MERRIMAC	CWM-10R-10.8G	LOT-83391	2023/03/24	2024/03/23
Wideband Radio Communication Tester	ROHDE & SCHWARZ	CMW500	161997	2022/11/24	2023/11/23

ANNEX A HAC RF System Validation Result

E-Field Scan						
Mode	Frequency (MHz)	Input Power (mW)	Measured Value (dBV/m)	Target Value (dBV/m)	Deviation (%)	Limit (%)
CW	835	100	215.88	210.0	-2.80	±25
CW	1900	100	146.86	146.1	-0.52	±25

System check at 835.00 MHz

Date of measurement: 30/6/2023

Experimental Conditions

Probe	SN_0722_EPH50
Signal	CW
Band	CW835
Channels	middle
Frequency (MHz)	835.00

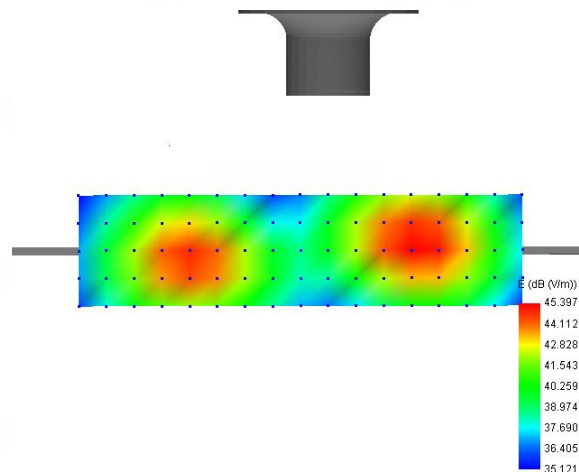
Results

E-field average [dB(V/m)]	215.88
Right E-field maximum [dB(V/m)]	215.56
Left E-field maximum [dB(V/m)]	216.51

Scan parameter

Scan area: length (mm), width (mm)	20.00, 80.00
Measurement point spacing (mm)	5
distance to reference plane (mm)	10.00
X and Y offset with the reference point (mm)	0.00, 0.00
Number of measurement points	85

RF audio interference near field



System check at 1900.00 MHz

Date of measurement: 30/6/2023

Experimental Conditions

Probe	SN_0722_EPH50
Signal	CW
Band	CW1900
Channels	middle
Frequency (MHz)	1900.00

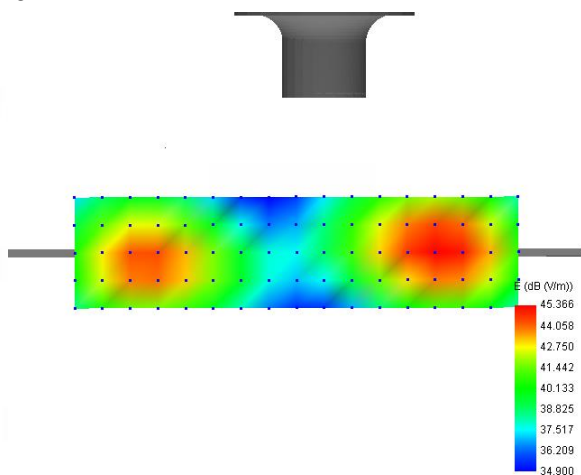
Results

E-field average [dB(V/m)]	146.86
Right E-field maximum [dB(V/m)]	146.32
Left E-field maximum [dB(V/m)]	147.91

Scan parameter

Scan area: length (mm), width (mm)	20.00, 80.00
Measurement point spacing (mm)	5
distance to reference plane (mm)	10.00
X and Y offset with the reference point (mm)	0.00, 0.00
Number of measurement points	85

RF audio interference near field



ANNEX B HAC RF Measurement Result

Band	Channel	Frequency (MHz)	RF audio interference level [dB(V/m)]	Device compliant	Plot
GSM850	Low (128)	824.2MHz	33.40	Yes	/
	Middle(190)	836.6MHz	34.11	Yes	1#
	High(251)	848.8MHz	33.52	Yes	/
GSM1900	Low (512)	1850.2MHz	27.22	Yes	/
	Middle(661)	1880.0MHz	27.20	Yes	/
	High(810)	1909.8MHz	28.08	Yes	2#

Measurement at GSM850

Date of measurement: 30/6/2023

Experimental Conditions

Probe	SN_0722_EPH50
Signal	GSM
Band	GSM850
Channels	middle
Channels Number	190
Frequency (MHz)	836.60
MIF	3.30

Results

Maximum value of RF audio interference field [dB(V/m)]	34.11
Category	M4
Measurement status	Complete

Grid visualisation

Legend:

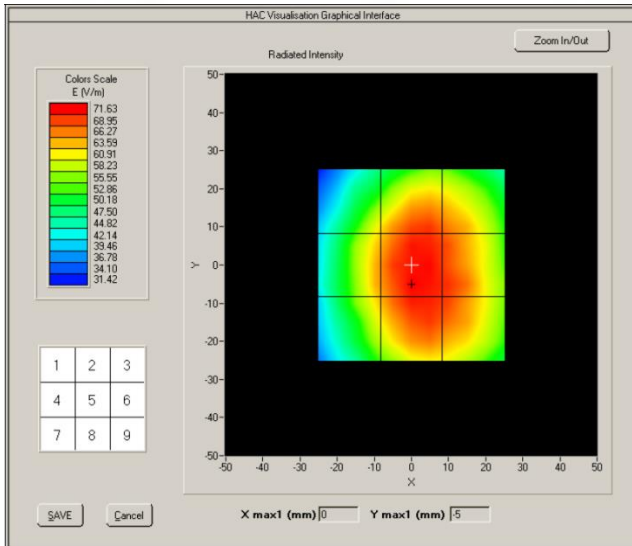
- Blue cells are excluded
- Red cell contains the maximum RF audio interference level

Cell 1: 32.80 dB(V/m)	Cell 2: 33.84 dB(V/m)	Cell 3: 33.39 dB(V/m)
Cell 4: 33.40 dB(V/m)	Cell 5: 34.11 dB(V/m)	Cell 6: 33.85 dB(V/m)
Cell 7: 33.18 dB(V/m)	Cell 8: 34.04 dB(V/m)	Cell 9: 33.81 dB(V/m)

Scan parameter

Scan area: length (mm), width (mm)	50.00, 50.00
Measurement point spacing (mm)	5
distance to reference plane (mm)	15.00
X and Y offset with the reference point (mm)	0.00, 0.00
Number of measurement points	121

RF audio interference near field



Measurement at GSM1900

Date of measurement: 30/6/2023

Experimental Conditions

Probe	SN_0722_EPH50
Signal	GSM
Band	GSM1900
Channels	High
Channels Number	810
Frequency (MHz)	1909.80
MIF	3.30

Results

Maximum value of RF audio interference field [dB(V/m)]	28.08
Category	M4
Measurement status	Complete

Grid visualisation

Legend:

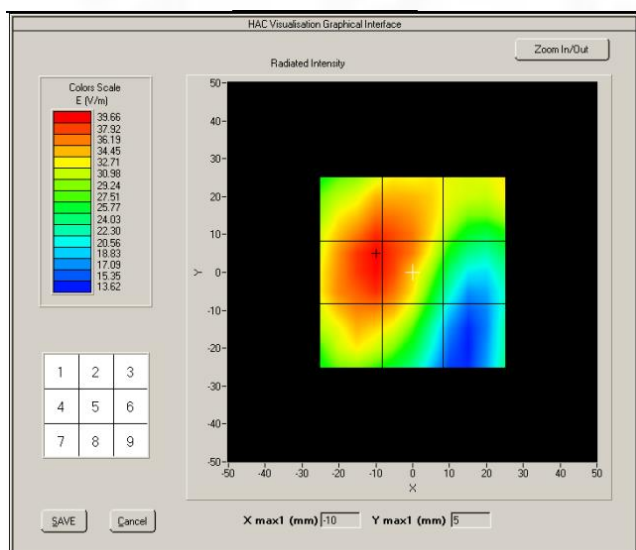
- Blue cells are excluded
- Red cell contains the maximum RF audio interference level

Cell 1: 27.71 dB(V/m)	Cell 2: 27.62 dB(V/m)	Cell 3: 26.39 dB(V/m)
Cell 4: 27.98 dB(V/m)	Cell 5: 28.08 dB(V/m)	Cell 6: 25.85 dB(V/m)
Cell 7: 27.38 dB(V/m)	Cell 8: 27.14 dB(V/m)	Cell 9: 23.81 dB(V/m)

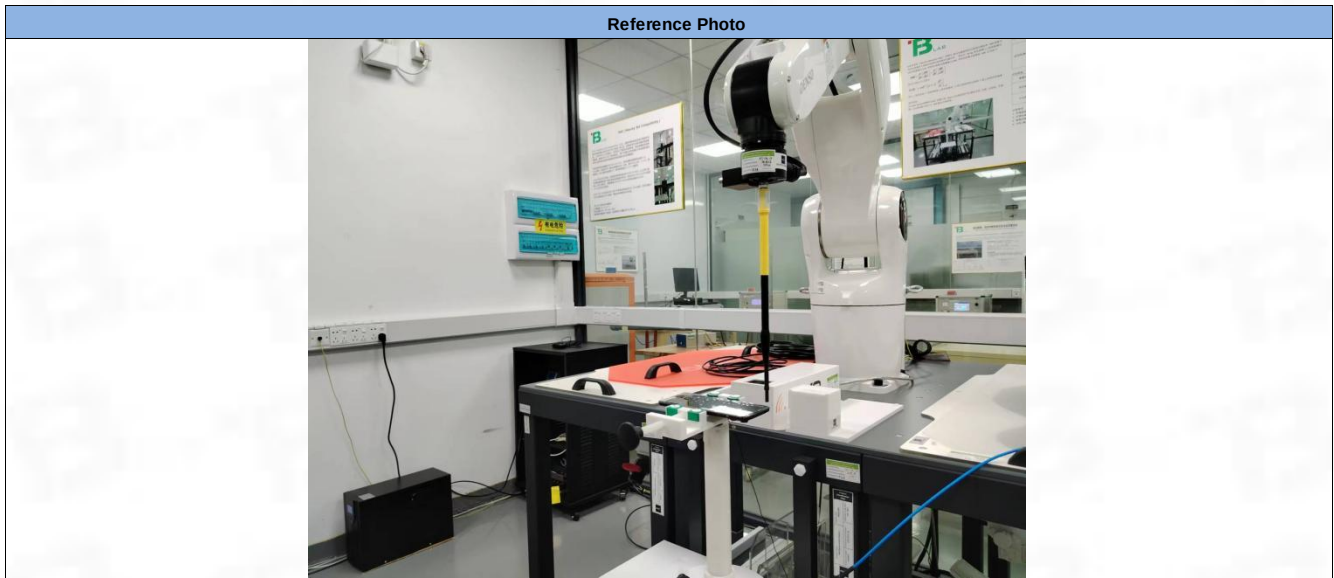
Scan parameter

Scan area: length (mm), width (mm)	50.00, 50.00
Measurement point spacing (mm)	5
distance to reference plane (mm)	15.00
X and Y offset with the reference point (mm)	0.00, 0.00
Number of measurement points	121

RF audio interference near field



ANNEX C Test Setup Photos



ANNEX D EUT External & Internal Photos

Please refer to RF Report.

ANNEX E Calibration Information

Please refer the document "Calibration.pdf".



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